

Search Notes

Application/Control No.

10/665,253

Examiner

Hien N. Nguyen

Applicant(s)/Patent under
Reexamination

EPSTEIN

Art Unit

2824

SEARCHED

Class	Subclass	Date	Examiner
365	158	5/2/2005	HN
	171		
977	DIG.1.		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	5/2/2005	HN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner